

Notice of References Cited	Application/Control No. 09/303,409	Applicant(s)/Patent Under Reexamination FELDMAN ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,920,385	04-1990	Clarke et al.	356/237.2
	B	US-5,528,368	06-1996	Lewis et al.	356/456
	C	US-5,149,547	09-1992	Gill, Antony	425/145
	D	US-5,220,403	06-1993	Batchelder et al.	356/450
	E	US-6,002,480	12-1999	Izatt et al.	356/479
	F	US-5,053,173	10-1991	Sticht, Walter	264/39
	G	US-6,155,331	12-2000	Langer et al.	164/456
	H	US-5,208,648	05-1993	Batchelder et al.	356/237.1
	I	US-5,606,413	02-1997	Bellus et al.	356/326
	J	US-6,045,502	04-2000	Eppstein et al.	600/306
	K	US-6,441,901	08-2002	McFarland et al.	356/364
	L	US-4,498,860	02-1985	Gahan, Geoffrey D.	425/562
	M	US-6,214,560	04-2001	Yguerabide et al.	435/7.1

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Thermal desorption behavior of absorbed material on wafer surfaces" T. Jimbo, IEEE 0-7803-3752-2/97, 1997
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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	B	US-5,943,127 ✓	08-1999	Feldman et al.	356/237.2
	C	US-6,075,608 ✓	06-2000	Feldman et al.	356/406
	D	US-5,859,708 ✓	01-1999	Feldman, Sandra Freedman	356/406
	E	US-6,485,413 ✓	11-2002	Boppart et al.	600/160
	F	US-			
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